SDAS045B - AUGUST 1984 - REVISED MAY 1986

- High Capacitive Drive Capability
- 'ALS1832A Has Typical Delay Time of 5 ns (C_L = 50 pF) and Typical Power Dissipation of 5.3 mW per Gate
- 'AS1832 Has Typical Delay Time of 3.9 ns (C_L = 50 pF) and Typical Power Dissipation of Less than 17 mW per Gate
- Center V_{CC} and GND Configuration Provides Minimum Lead inductance in High Current Switching Applications
- Package Options include Plastic Small Outline Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs
- Dependable Texas Instruments Quality and Reliability

description

These devices contain six independent 2-input OR drivers. They perform the Boolean functions Y = A + B or $Y = \overline{A} \bullet \overline{B}$ in positive logic.

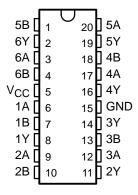
The center pin configuration used in the 'ALS1832A and 'AS1832 provides a reduction of lead inductance when compared to the 'ALS832A and 'AS832B. This reduction of lead inductance will minimize noise generated onto either the V_{CC} or GND bus. This reduction is significant in high current switching applications.

The SN54ALS1832A and SN54AS1832 are characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ALS1832A and SN74AS1832 are characterized for operation from 0°C to 70°C.

FUNCTION TABLE (each driver)

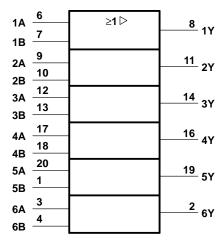
	•	
INP	UTS	OUTPUT
Α	В	Υ
Н	Χ	Н
Х	Н	Н
L	L	L

SN54ALS1832A, SN54AS1832...J PACKAGE SN74ALS1832A, SN74AS1832...N PACKAGE (TOP VIEW)



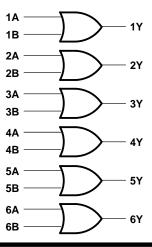
Use 'ALS832A or 'AS832B for chip carrier option.

logic symbol†



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



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SDAS045B - AUGUST 1984 - REVISED MAY 1986

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V _{CC}		7 V
Input voltage		7 V
	SN54ALS1832A	
	SN74ALS1832A	0°C to 70°C
Storage temperature range		−65°C to 150°C

recommended operating conditions

		SN5	4ALS18	32A	SN74ALS1832A		UNIT	
		MIN	NOM	MAX	MIN	NOM	MAX	UNII
Vcc	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
VIL	Low-level input voltage			0.7			0.8	V
IOH	High-level output current			-12			-15	mA
loL	Low-level output current			12			24	mA
T _A	Operating free-air temperature	-55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST CONDITIONS		SN54	SN54ALS1832A			SN74ALS1832A			
PARAMETER			MIN	TYP [†]	MAX	MIN	TYP†	MAX	UNIT	
VIK	V _{CC} = 4.5 V,	I _I = -18 mA			-1.2			-1.2	V	
	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -0.4 \text{ mA}$	V _{CC} -2			V _{CC} -2				
Vou	$V_{CC} = 4.5 \text{ V},$	$I_{OH} = -3 \text{ mA}$	2.4	3.2		2.4	3.2		V	
VOH	$V_{CC} = 4.5 \text{ V},$	$I_{OH} = -12 \text{ mA}$	2						V	
	$V_{CC} = 4.5 \text{ V},$	$I_{OH} = -15 \text{ mA}$				2				
Va	$V_{CC} = 4.5 \text{ V},$	$I_{OL} = 12 \text{ mA}$		0.25	0.4		0.25	0.4	V	
VOL	$V_{CC} = 4.5 \text{ V},$	$I_{OL} = 24 \text{ mA}$					0.35	0.5	V	
lį	$V_{CC} = 5.5 \text{ V},$	V _I = 7 V			0.1			0.1	mA	
lН	$V_{CC} = 5.5 \text{ V},$	V _I = 2.7 V			20			20	μΑ	
I _Ι L	$V_{CC} = 5.5 \text{ V},$	V _I = 0.4 V			-0.1			-0.1	mA	
1 ₀ ‡	V _{CC} = 5.5 V,	V _O = 2.25 V	-30		-112	-30		-112	mA	
IССН	$V_{CC} = 5.5 \text{ V},$	V _I = 4.5 V		6	9		6	9	mA	
^I CCL	$V_{CC} = 5.5 \text{ V},$	V _I = 0		9.5	16		9.5	16	mA	

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

switching characteristics (see Note 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{CC} = 5 \text{ V},$ $C_{L} = 50 \text{ pF},$ $R_{L} = 500 \Omega,$ $T_{A} = 25^{\circ}\text{C}$ 'ALS1832A TYP	SN54ALS	C _L = 50 R _L = 50 T _A = M	-		UNIT
^t PLH	A or B	Y	6	2	11	2	9	ns
t _{PHL}	A OI B	•	4	1	10	1	8	113

NOTE 1: Load circuit and voltage waveforms are shown in Section 1.



[‡] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, los.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V _{CC}		7 V
Input voltage		7 V
Operating free-air temperature range:	SN54AS1832	-55°C to 125°C
	SN74AS1832	0°C to 70°C
Storage temperature range		-65°C to 150°C

recommended operating conditions

		SN	54AS18	32	SN74AS1832		UNIT	
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
V _{IL}	Low-level input voltage			0.8			0.8	V
IOH	High-level output current			-40			-48	mA
lOL	Low-level output current			40			48	mA
TA	Operating free-air temperature	-55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST CONDITIONS		SN	SN54AS1832			SN74AS1832			
PARAMETER			MIN	TYP†	MAX	MIN	TYP†	MAX	UNIT	
VIK	V _{CC} = 4.5 V,	I _I = -18 mA			-1.2			-1.2	V	
	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -2 \text{ mA}$	V _{CC} -2			V _{CC} -2				
V0	$V_{CC} = 4.5 \text{ V},$	$I_{OH} = -3 \text{ mA}$	2.4	3.2		2.4	3.2		V	
VOH	$V_{CC} = 4.5 \text{ V},$	$I_{OH} = -40 \text{ mA}$	2						V	
	$V_{CC} = 4.5 \text{ V},$	$I_{OH} = -48 \text{ mA}$				2				
Vo	$V_{CC} = 4.5 \text{ V},$	$I_{OL} = 40 \text{ mA}$		0.25	0.5				V	
VOL	$V_{CC} = 4.5 \text{ V},$	$I_{OL} = 48 \text{ mA}$					0.35	0.5	V	
lį	$V_{CC} = 5.5 \text{ V},$	V _I = 7 V			0.1			0.1	mA	
lН	$V_{CC} = 5.5 \text{ V},$	V _I = 2.7 V			20			20	μΑ	
I _Ι Γ	$V_{CC} = 5.5 \text{ V},$	$V_{I} = 0.4 V$			-0.5			-0.5	mA	
10 [‡]	V _{CC} = 5.5 V,	V _O = 2.25 V	-50		-200	-50		-200	mA	
Iссн	$V_{CC} = 5.5 \text{ V},$	V _I = 4.5 V		11	17		11	17	mA	
^I CCL	$V_{CC} = 5.5 \text{ V},$	V _I = 0		22	36		22	36	mA	

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

switching characteristics (see Note 1)

PARAMETER	FROM (INPUT)	то (оитрит)		$C_L = 50$ $R_L = 50$		x	UNIT
t _{PLH}	A or B	V	1	7	1	6.3	ns
t _{PHL}	A 01 B	ı	1	7	1	6.3	113

NOTE 1: Load circuit and voltage waveforms are shown in Section 1.



[‡] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

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